

Specification of Test Bench

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1 Scope

This document discusses the test suite specifications. It provides examples and variations of different types of defects considered for generating the test suites.

2 Overview of Test Suites

Based on [1] Annex A (Source Code Weaknesses), we prepare a set of defect types. From [1] Annex A, we select the defects related to embedded systems. Moreover, we add some defect types related to dynamic memory allocation, error handling, multithreading, which can be detected by tools but not mentioned in [1] Annex A.

Table 1 depicts the splitting of the 9 different defect types into specific number of defect sub-types. These defect variations are shortlisted to make the test bench used for evaluation of various tools.

Table 1 Defect Types

	Table I Delete Types					
#	Defect Type	Subtype samples	# of Defect Subtypes			
1	Static memory defects	Static buffer overrun, etc.	2			
2	Dynamic memory defects	Dynamic buffer overrun, etc.	5			
3	Stack related defects	Stack overflow, etc.	3			
4	Numerical defects	Division by zero, etc.	7			
5	Resource management defects	Invalid memory access to already freed area, etc.	7			
6	Pointer related defects	Dereferencing a NULL pointer, etc.	7			
7	Concurrency defects	Dead lock, etc.	8			
8	Inappropriate code	Dead code, etc.	7			
9	Misc defects	Uninitialized variables, etc.	5			
Total			51			

Table 2 gives a detailed specification of the test bench in terms of the defect sub-type classification. This depicts the fact that the test bench not only supports defects, but also supports defect-free variation to evaluate the false-positive scenarios.

Table 2 Specification of Test Bench

#	Defect Subtype	Defect Type	w/ Defect	w/o Defect
1	Bit shift bigger than integral type or negative	Numerical	17	17
2	Dynamic buffer overrun	Dynamic memory	32	32
3	Dynamic buffer underrun	Dynamic memory	39	39
4	Comparison NULL with function pointer	Pointer related	2	2
5	Contradict conditions	Inappropriate code	10	10
6	Integer precision lost because of cast	Numerical	19	19
7	Data overflow	Numerical	25	25
8	Data underflow	Numerical	12	12

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9	Dead code	Inappropriate code	13	13
10	Dead lock	Concurrency	5	5
11	Deletion of data structure sentinel	Dynamic memory	3	3
12	Double free	Resource management	12	12
13	Double lock	Concurrency	4	4
14	Double release	Concurrency	6	6
15	Unintentional endless loop	Misc	9	9
16	Free non dynamically allocated memory	Resource management	16	16
17	Free NULL pointer	Pointer related	14	14
18	Bad cast of a function pointer	Pointer related	15	15
19	Return value of function never checked	Inappropriate code	16	16
20	Improper error handling	Inappropriate code	4	4
21	Improper termination of block	Inappropriate code	4	4
22	Useless assignment	Misc	1	1
23	Bad extern type for global variable	Misc	6	6
24	Invalid memory access to already freed area	Resource management	17	17
25	Assign small buffer for structure	Dynamic memory	11	11
26	Live lock	Concurrency	1	1
27	Locked but never unlock	Concurrency	9	9
28	Memory allocation failure	Resource management	16	16
29	Memory leakage	Resource management	18	18
30	Non void function does not return value	Misc	4	4
31	Dereferencing a NULL pointer	Pointer related	17	17
32	Static buffer overrun	Static memory	54	54
33	Memory copy at overlapping areas	Dynamic memory	2	2
34	Power related errors	Numerical	29	29
35	Incorrect pointer arithmetic	Pointer related	2	2
36	Race condition	Concurrency	8	8
37	Redundant conditions	Inappropriate code	14	14
38	Return of a pointer to a local variable	Resource management	2	2
39	Integer sign lost because of unsigned cast	Numerical	19	19
40	Long lock	Concurrency	3	3
41	Cross thread stack access	Stack related	6	6
42	Stack overflow	Stack related	7	7
43	Stack underrun	Stack related	7	7
44	Static buffer underrun	Static memory	13	13
45	Uninitialized memory access	Resource management	15	15
46	Uninitialized pointer	Pointer related	16	16
47	Uninitialized variable	Misc	15	15
48	Unlock without lock	Concurrency	8	8
49	Unused variable	Inappropriate code	7	7





50 51	Wrong arguments passed to a function pointer Division by zero	Pointer related Numerical	18	18 16
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Table 3 shows the relation between the various defect sub-types used for analysis the file names as specified in the test suite.

Table 3 Relation between Defect Sub-Type and Test Suite Files

#	Defect Sub-type	Defect Type and Te	File Name
1	Bit shift bigger than integral type or negative	Numerical defects	bit_shift
2	Dynamic buffer overrun	Dynamic memory defects	buffer_overrun_dynamic
3	Dynamic buffer underrun	Dynamic memory defects	buffer_underrun_dynamic
4	Comparison NULL with function pointer	Pointer related defects	cmp_funcadr
5	Contradict conditions	Inappropriate code	conflicting_cond
6	Integer precision lost because of cast	Numerical defects	data_lost
7	Data overflow	Numerical defects	data_overflow
8	Data underflow	Numerical defects	data_underflow
9	Dead code	Inappropriate code	dead_code
10	Dead lock	Concurrency defects	dead_lock
11	Deletion of data structure sentinel	Dynamic memory defects	deletion_of_data_structure_sentinel
12	Double free	Resource management defects	double_free
13	Double lock	Concurrency defects	double_lock
14	Double release	Concurrency defects	double_release
15	Unintentional endless loop	Misc defects	endless_loop
16	Free non dynamically allocated memory	Resource management defects	free_nondynamic_allocated_memory
17	Free NULL pointer	Pointer related defects	free_null_pointer
18	Bad cast of a function pointer	Pointer related defects	func_pointer
19	Return value of function never checked	Inappropriate code	function_return_value_unchecked
20	Improper error handling	Inappropriate code	improper_error_handling
21	Improper termination of block	Inappropriate code	improper_termination_of_block
22	Useless assignment	Misc defects	insign_code
23	Bad extern type for global variable	Misc defects	invalid_extern
24	Invalid memory access to already freed area	Resource management defects	invalid_memory_access
25	Assign small buffer for structure	Dynamic memory defects	littlemem_st
26	Live lock	Concurrency defects	livelock
27	Locked but never unlock	Concurrency defects	lock_never_unlock
28	Memory allocation failure	Resource management defects	memory_allocation_failure
29	Memory leakage	Resource management defects	memory_leak
30	Non void function does not return value	Misc defects	not_return
31	Dereferencing a NULL pointer	Pointer related defects	null_pointer
32	Static buffer overrun	Static memory defects	overrun_st
33	Memory copy at overlapping areas	Dynamic memory defects	ow_memcpy



34	Power related errors	Numerical defects	pow_related_errors
35	Incorrect pointer arithmetic	Pointer related defects	ptr_subtraction
36	Race condition	Concurrency defects	race_condition
37	Redundant conditions	Inappropriate code	redundant_cond
38	Return of a pointer to a local variable	Resource management defects	return_local
39	Integer sign lost because of unsigned cast	Numerical defects	sign_conv
40	Long lock	Concurrency defects	sleep_lock
41	Cross thread stack access	Stack related defects	st_cross_thread_access
42	Stack overflow	Stack related defects	st_overflow
43	Stack underrun	Stack related defects	st_underrun
44	Static buffer underrun	Static memory defects	underrun_st
45	Uninitialized memory access	Resource management defects	uninit_memory_access
46	Uninitialized pointer	Pointer related defects	uninit_pointer
47	Uninitialized variable	Misc defects	uninit_var
48	Unlock without lock	Concurrency defects	unlock_without_lock
49	Unused variable	Inappropriate code	unused_var
50	Wrong arguments passed to a function pointer	Pointer related defects	wrong_arguments_func_pointer
51	Division by zero	Numerical defects	zero_division



3 Detailed Specification

3.1 Bit Shift Bigger Than Integral Type or Negative

This defect variation helps in identifying *Numerical defects*, which are related to the size of bit shift operation being larger than the size of operands.

3.2 Dynamic Buffer Overrun

This defect variation identifies *Dynamic Memory defects*, which are related to memory access outside dynamically allocated memory space.

3.3 Dynamic Buffer Underrun

This defect variation identifies *Dynamic Memory defects*, which are related to memory access lower than the bounds of the dynamic allocated memory space.

3.4 Comparison NULL with Function Pointer

This defect variation identifies *Pointer related defects*, which are related to a function address comparison with NULL. Usually, this operation is a misuse case that is supposed to be a coding error of a function call with a missing ().

3.5 Contradict Conditions

This defect variation identifies *Inappropriate code*, which are related to validating the conditions that conflict each other.

3.6 Integer Precision Lost Because of Cast

This defect variation identifies *Numerical defects*, which assign a variable of a larger variable type to another variable with smaller data size. The result of which is some information of assigned variable is lost.

3.7 Data Overflow

This defect variation identifies Numerical defects, which are illustrated in brief below.

- Integer the result value of an operation exceed the maximum value of operands. As a result, the result value is incorrect.
 - Signed: Maximum Value+1→Minimum Value (Alternate Sign)
 - o Unsigned: Maximum Value+1→0
- Floating Point the result value of an operation exceed the maximum value of operands. As a result, the result value is infinite.
- Positive Overflow: Maximum Value + Positive Value -> Infinite Positive
- Negative Overflow: Minimum Value Positive Value -> Infinite Negative

3.8 Data Underflow

This defect variation identifies Numerical defects, which are illustrated in brief below.



- Integer…the result value is under the minimum value of operands. As a result, the result value is incorrect.
 - o Signed: Minimum Value-1→Maximum Value (Alternate Sign)
 - Unsigned : 0-1→Maximum Value
- Floating point…the result value is under the minimum value of operands. As a result, the result value is incorrect.

Positive Underflow: Maximum Value/2→0

Negative Underflow: Minimum Value2→0

3.9 Deadcode

This defect variation identifies *Inappropriate code*, which validates the existing code that is never executed.

3.10 Deadlock

This defect variation identifies *Concurrency defects*. Deadlock conditions occur when resources with exclusive control are implemented inappropriately i.e. if different orders of locks are sequenced among tasks.

3.11 Deletion of Data Structure Sentinel

This defect variation identifies *Dynamic memory defects*. The accidental deletion of a data-structure sentinel can cause serious programming logic problems. Often data-structure sentinels are used to mark structure of data. A common example of this is the null character at the end of strings. Another common example is linked lists, which may contain a sentinel to mark the end of the list. It is dangerous to allow this type of control data to be easily accessible. Therefore, it is important to protect from the deletion or modification outside of some wrapper interface, which provides safety.

3.12 Double Free

This defect variation identifies *Resource Management defects*, which validates an attempt to free heap memory, which is already "free".

3.13 Double Lock

This defect variation identifies *Concurrency defects*, which validates if in the same task, the same resource is locked twice, or is never unlocked.

3.14 Double Release

This defect variation identifies *Concurrency defects*, which validates if in the same task, the same resource is unlocked twice.

3.15 Unintentional Endless Loop

This defect variation identifies some *Miscellaneous defects*, which validates no termination of a program due to an infinite loop.



3.16 Free Non Dynamically Allocated Memory

This defect variation identifies *Resource Management defects*, which validates an attempt to free a memory location that was not allocated dynamically.

3.17 Free NULL Pointer

This defect variation identifies *Pointer Related defects*, which validates an attempt to free a pointer which is NULL.

3.18 Bad Cast of a Function Pointer

This defect variation identifies *Pointer Related defects*, which validates an attempt to assign a function pointer to other function pointer that has different arguments and/or return value.

3.19 Return Value of Function Never Checked

This defect variation identifies *Inappropriate code*, which validates if a return value from a function is never evaluated.

3.20 Improper Error Handling

This defect variation identifies *Inappropriate code* in C++ programing, which validates if detected errors are handled properly. For instance, a try block without a catch or throw.

3.21 Improper Termination of Block

This defect variation identifies *Inappropriate code* as in the improper termination of a block of code.

3.22 Useless Assignment

This defect variation identifies *Miscellaneous defects*, which validates if within a certain block of statements, there exists some meaningless assignment.

3.23 Bad Extern Type for Global Variable

This defect variation identifies *Miscellaneous defects*, which validates a global variable being used as a different type in a different file.

3.24 Invalid Memory Access to Already Freed Area

This defect variation identifies *Resource Management defects*, which validates access to a memory location, which is already freed.

3.25 Assign Small Buffer for Structure

This defect variation identifies *Dynamic memory defects*. These defects are used to validate an allocation of a smaller array buffer to a larger structure pointer for data access. When such a structure pointer is accessed, it could result in invalid data read or a buffer overrun.



3.26 Live Lock

This defect variation identifies *Concurrency defects*. Live lock is a condition that occurs when two or more processes continually changes their state in response to changes in the other processes. The result is that none of the processes will complete. An analogy is when two people meet in a hallway and each tries to step around the other but they end up swaying from side to side getting in each other's way as they try to get out of the way.

3.27 Locked but Never Unlock

This defect variation identifies *Concurrency defects*, which validates if a resource is locked from access but never unlocked for access.

3.28 Memory Allocation Failure

This defect variation identifies *Resource Management defects*, which validates a memory allocation failure due to insufficient memory. Typically a memory allocation failure would happen when there is a heap overflow condition.

3.29 Memory Leakage

This defect variation identifies *Resource Management defects*, which validates a memory allocation on the heap and but a failure to "free" it, resulting in memory holes.

3.30 Non Void Function does not Return Value

This defect variation identifies *Miscellaneous defects*, which evaluates if a function does not return a value even though its return type is non-void.

3.31 Dereferencing a NULL pointer

This defect variation identifies *Pointer Related defects*, which validates access to an address pointed by a NULL pointer.

3.32 Static Buffer Overrun

This defect variation identifies *Static Memory defects*, which validates an access to the memory area that is not reserved statically, e.g., an oversized index for an array

3.33 Memory Copy at Overlapping Areas

This defect variation identifies *Dynamic Memory defects*, which validates data overwriting while copying of array elements continuously.

3.34 Power Related Errors

This defect variation identifies *Numerical defects*, which validate use of large data as a result of "pow" operations. Double values, which are given as an input to "pow" functions, may not be able to store those big values. The result can be sometimes larger than the maximum value double can hold. Table 4 depicts a tabulation of the corner cases while using "pow" functionality.



- Positive Overflow: Maximum Value ^ Positive Value = Positive Overflow
- Negative Overflow: Minimum Value ^ Negative Value = Negative overflow or underflow

Table 4 Corner Cases of Pow (x,y)

Base	Positive Large Number	Negative Large	Small Absolute	Small Absolute
Exponent	> 1	Number < -1	Number 0 < x < 1	Number -1 < x < 0
Positive Large and Even Number > 1	Overflow	Overflow	Losing precision	Losing precision
Positive Large and Odd Number > 1	Same as above	Underflow	Same as above	Same as above
Negative Large and Even Number > 0	Overflow	Overflow	Loosing Precision	Loosing Precision
Negative Large and Odd Number > 0	Same as above	Same as above	Same as above	Underflow
Positive Small Number 1 > y > 0	Same as above	Same as above	Losing precision	Complex Number (Not Real Number)
Negative Small Number -1 < y < 0	Same as above	Same as above	Same as above	Same as above

3.35 Incorrect Pointer Arithmetic

This defect variation identifies *Pointer Related defects*, which validates pointer arithmetic resulting to access different kinds of memory areas.

3.36 Race Condition

This defect variation identifies *Concurrency defects*, which validates a race condition. A race condition occurs when 2 or more threads are attempting to access shared data and write into the shared location at the same time. A scheduler can swap between threads at any point and hence the order at which the threads will attempt to access the shared data is unpredictable. Therefore, the result of the change in data is dependent on the thread-scheduling algorithm, i.e. both threads are 'racing' to access/change the data.

3.37 Redundant Condition

This defect variation identifies *Inappropriate code*, which validates any redundant conditions if they exist.

3.38 Return of a Pointer to a Local Variable

This defect variation identifies *Resource Management defects*, which validates if a returned pointer from a function call points to a local variable, and if the caller access the memory via the pointer.



3.39 Integer Sign Lost Because of Unsigned Cast

This defect variation identifies *Numerical defects*, which validates if the sign information is lost while assigning a signed variable to unsigned variable; If while an unsigned variable is assigned to a signed variable, and then the sign is alternated.

3.40 Long Lock

This defect variation identifies *Concurrency defects*, which validates the time-consuming steps between lock and unlock.

3.41 Cross Thread Stack Access

This defect variation identifies *Stack Related defects*, which validates a thread accessing a different thread's stack

3.42 Stack Overflow

This defect variation identifies *Stack Related defects*, which validates the size of used stack exceeding the size of the prepared stack memory.

3.43 Stack Underrun

This defect variation identifies *Stack Related defects*, which validates a memory access lower than the bounds of a declared stack.

3.44 Static Buffer Underrun

This defect variation identifies *Static Memory defects*, which validates a memory access to lower address allocated statically (arrays).

3.45 Uninitialized Memory Access

This defect variation identifies *Resource Management defects*, which validates a memory access/read of a memory location without initialization.

3.46 Uninitialized Pointer

This defect variation identifies *Pointer Related defects*, which validates if a pointer is accessed without initialization.

3.47 Uninitialized Variable

This defect variation identifies *Miscellaneous defects*, which validates an access to an uninitialized variable.

3.48 Unlock Without Lock

This defect variation identifies *Concurrency defects*, which validates if resource is being unlocked prior to being locked.



3.49 Unused Variable

This defect variation identifies *Inappropriate code*, which validates the existence of any unused variables in the code.

3.50 Wrong Arguments Passed to a Function Pointer

This defect variation identifies *Pointer Related defects*, which validates the different number of arguments or argument types passed to the function pointer.

3.51 Division by Zero

This defect variation identifies *Numerical defects*, which validates if an arithmetic expression is divided by zero or module operation is performed with zero.



4 Bibliography

[1] P. E. Black, M. Kass, M. Koo and E. Fong, "Source Code Security Analysis Tool Functional Specification Version 1.1," National Institute of Standards and Technology, Gaithersburg, 2011.